



1. Electrical Parameters

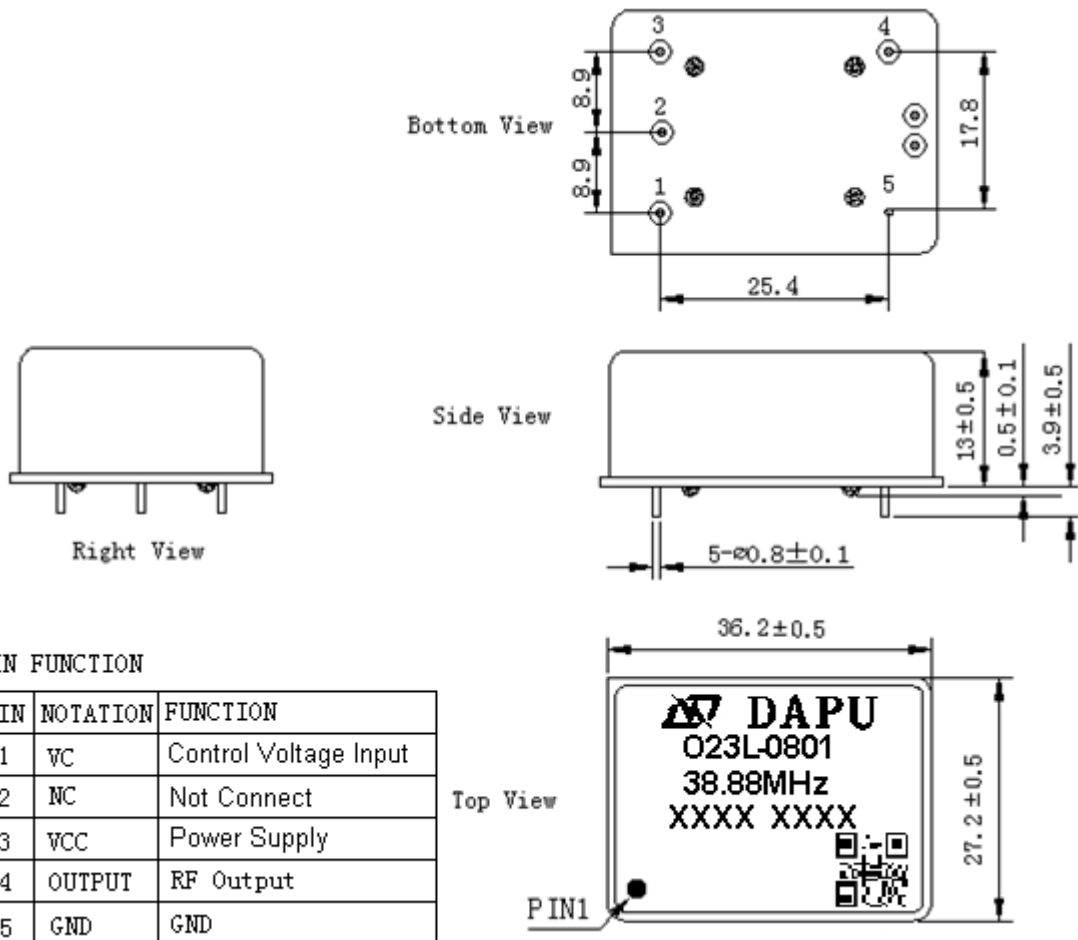
MODEL: O23L-0801-38.88MHz						
Item	Description	Parameters			Unit	Test Condition
		Min.	Typ.	Max.		
Output	Frequency	38.88			MHz	
	Output Waveform	HCMOS				
	Output High Voltage	3.6			V	$V_{cc}=5.0V, O_{load}=20pF$
	Output Low Voltage			0.5	V	$V_{cc}=5.0V, O_{load}=20pF$
	Duty Cycle	45	50	55	%	@50%
	Spurious Suppression			-60	dBc	
	Rise / Fall Time (10%~90%)			5	ns	
	Load	20			pF	
Frequency Stabilities	Frequency Tolerance vs. Operating Temperature Range	-0.1		+0.1	$\times 10^{-6}$	T_A varied from $-20^{\circ}C$ to $70^{\circ}C$, measurement referenced to frequency observed with $f_{ref}=(f_{max}+f_{min})/2, V_{cc}=5.0V, V_c=0V, O_{load}=20pF$, temperature variable speed less than $2^{\circ}C$ per minute.
	Initial Frequency Tolerance	-0.3		+0.3	$\times 10^{-6}$	Measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=5.0V, V_c=0V$, and after 15 minutes of operation, within 90 days after ex-works.
	Frequency Tolerance vs. Supply Voltage	-0.02		+0.02	$\times 10^{-6}$	measurement referenced to frequency observed $T_A=25^{\circ}C, V_{cc}$ varied from 4.75V to 5.25V, $V_c=0V$ and $O_{Load}=20pF$.
	Frequency Tolerance vs. Load	-0.02		+0.02	$\times 10^{-6}$	5% load change measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=5.0V, V_c=0V$, and $O_{Load}=20pF$.
	Short-Term Stability: Allan Variance			0.2	$\times 10^{-9}$	Temperature stability, no EMI\EMC or other interference, test after power for 1hour ref. to $25^{\circ}C$; 1s, using PN9000 equipment.
	Aging Tolerance Per Day	-0.01		+0.01	$\times 10^{-6}$	V_{cc}, V_c, T_A constant measurement referenced to frequency observed with $T_A=25^{\circ}C, V_{cc}=5.0V, V_c=0V$, and after 30 days of operation.
	Day fluctuation	-0.04		+0.04	$\times 10^{-6}$	
	Aging Tolerance 1 Year	-1		+1	$\times 10^{-6}$	
	Aging Tolerance 10 Years	-4		+4	$\times 10^{-6}$	



Power Supply	Supply Voltage	4.75	5.0	5.25	V	
	Steady Consumption			300	mA	@25°C
	Warm up current			700	mA	
Voltage Control Characteristics	Frequency Tuning Range	+6		+9	$\times 10^{-6}$	$V_c=-5.0V$. measurement referenced to $V_c=0V$
		-0.3		+0.3	$\times 10^{-6}$	$V_c=0V$. measurement referenced to exactly 38.88MHz
		-9		-6	$\times 10^{-6}$	$V_c=+5.0V$. measurement referenced to $V_c=0V$
	Linearity			10	%	
	Slope	Negative				
	Input Impedance	50			K Ω	
Phase Noise	Phase Noise		-85	-80	dBc/Hz	10Hz
			-115	-110		100Hz
			-125	-120		1KHz
			-135	-130		10KHz
			-145	-140		100KHz
Environmental Conditions	Jitter			100	ps	12KHz~1MHz
	Operable Temperature	-20		+70	°C	
	Storage Temperature	-50		+85	°C	
	ESD Level	Human Body Model, class2: 2000V to 4000V; ANSI/ESDA/JEDEC JS-001-2010.				
		Machine Model, class B: 200V to 400V; ANSI/ESDA/JEDEC JS-001-2010.				
	Moisture Sensitivity Level	Not humidity sensitive.				
	Vibration	Test Condition: 0.75mm ;acceleration:10g;10Hz~500Hz, one cycle per 30 min, test 2 hour. (3 times for each 3 directions X ,Y , Z), IEC 68-2-06 Test Fc.				
Shock	50g; 11ms; half sine wave (3 times for each 3 directions X, Y, Z), IEC 68-2-27 Test Ea/Severity 50A.					
Full Package Storage	Relative humidity (%)	20% ~70%				
	Temperature (°C)	-10~35°C				



2. Mechanical Structure (mm)



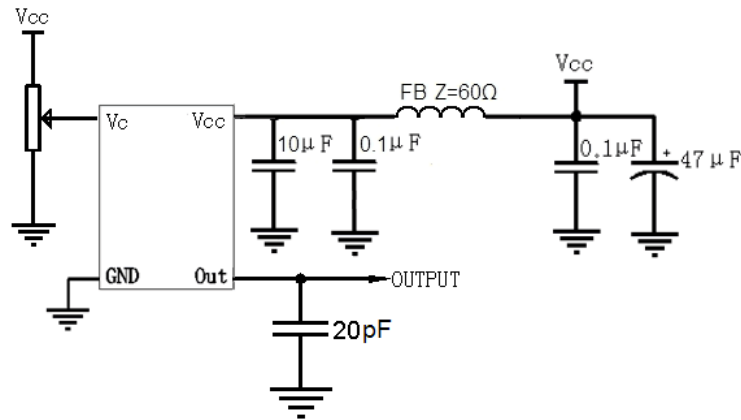
PIN FUNCTION

PIN	NOTATION	FUNCTION
1	VC	Control Voltage Input
2	NC	Not Connect
3	VCC	Power Supply
4	OUTPUT	RF Output
5	GND	GND

- Note1:** Tolerance ±0.2mm without mark
- Note2:** The first two xx representative: week
After two xx representative: year
At last four xxxx representative: serial number
- Note3:** Referential weight 17g
- Note4:** NC is not connect



3. Test Circuit



4. Reflow Soldering Curve (RoHS)



5. Package (mm)

